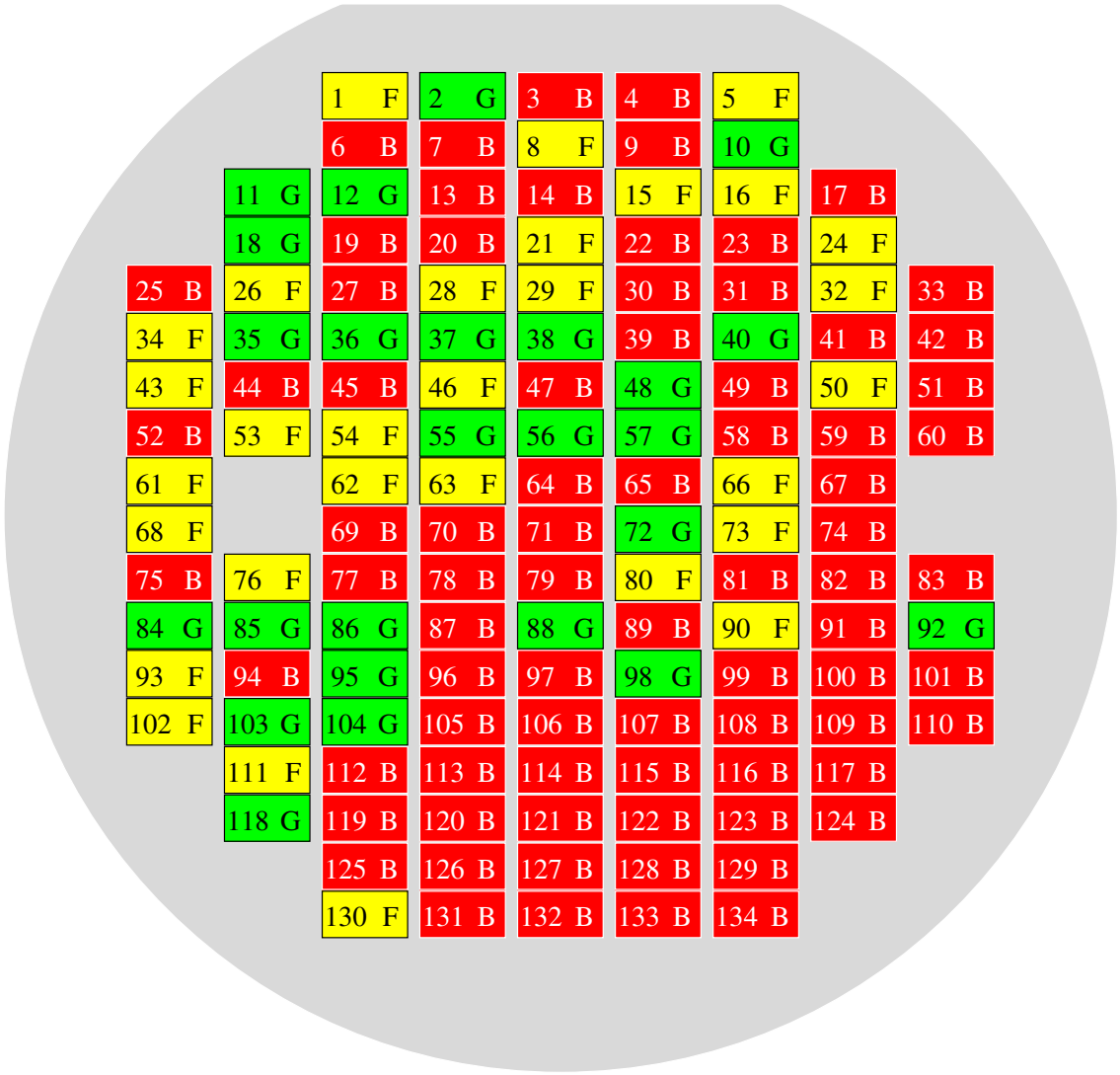
Die quality map for wafer 222 s/n: 21316-15-10

Date: 10/26/99



# B	Bad die
# F	Fair die
# G	Good die
# N	No info
# *	Manually tagged